


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582815	<b>Applicant(s)/Patent Under Reexamination</b>  AHN, CHANG-JUN
	<b>Examiner</b>  ALBERT T CHOU	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
370	203, 208, 210	12/19/2008	AC
375	229, 260, 264	1/6/2009	AC

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search - EAST	12/19/2008	AC
Inventor Search - EAST	1/6/2009	AC
Inventor Search - EAST	5/6/2009	AC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	208, 210 (updated)	5/6/2009	AC
375	229, 260, 264 (updated)	5/6/2009	AC

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